Regarding the change of names mentioned in the document, such as Mitsubishi Electric and Mitsubishi XX, to Renesas Technology Corp.

The semiconductor operations of Hitachi and Mitsubishi Electric were transferred to Renesas Technology Corporation on April 1st 2003. These operations include microcomputer, logic, analog and discrete devices, and memory chips other than DRAMs (flash memory, SRAMs etc.) Accordingly, although Mitsubishi Electric, Mitsubishi Electric Corporation, Mitsubishi Semiconductors, and other Mitsubishi brand names are mentioned in the document, these names have in fact all been changed to Renesas Technology Corp. Thank you for your understanding. Except for our corporate trademark, logo and corporate statement, no changes whatsoever have been made to the contents of the document, and these changes do not constitute any alteration to the contents of the document itself.

Note: Mitsubishi Electric will continue the business operations of high frequency & optical devices and power devices.

Renesas Technology Corp. Customer Support Dept. April 1, 2003



8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

DESCRIPTION

The M5M5W817KT is a family of low voltage 8Mbit static RAMs organized as 524288-words by 16-bit / 1048576-words by 8-bit, fabricated by Mitsubishi's high-performance 0.18 μ m CMOS technology.

The M5M5W817KT is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

The M5M5W817KT is packaged in a 52pin- μ TSOP with the outline of 10.79mm x 10.49mm, and pin pitch of 0.40mm. It gives the best solution for a compaction of mounting area as well as flexibility of wiring pattern of printed circuit boards.

The operating temperature range is -40 \sim +85 $^{\circ}$ C

FEATURES

- Single 2.7~3.6V power supply
- Small stand-by current: 0.1µA (2.0V, typ.)
- No clocks, No refresh
- Data retention supply voltage =2.0~3.6V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- By te function (x8 mode) available by By te# & A-1.
- Process technology: 0.18µm CMOS
- Package: 52pin 10.79mm x 10.49mm μTSOP [0.4mm pin pitch]

		_				Stand-b	y curre	ent		Active
Operating	Part name		Access time	* Typ	ical		Ratings	s (max	.)	current
temperature		Supply	max.	25ºC	40°C	25°C	40°C	70°C	85ºC	Icc1 (3.3V, Typ.)
-40 ~ +85°C	M5M5W817KT -70HI	2.7 ~ 3.6V	70ns	1.0	1.2	5	8	20	40	30mA (10MHz) 5mA (1MHz)

PIN CONFIGURATION

A16 A14 2 51 BYTE# A13 3 50 BC2# A12 4 49 GND 5 A11 BC1# 48 A10 6 47 DQ16/A-1 7 A9 46 DQ8 Α8 8 45 DQ15 NC 9 44 DQ7 S1# 10 43 DQ14 W# 11 42 DQ6 NC 12 41 DQ13 NC 13 40 DQ5 VCC 14 39 NC S2 15 38 DQ12 NC 16 37 DQ4 NC 17 36 DQ11 35 A18 18 DQ3 19 34 DQ10 A17 20 DQ2 Α7 33 21 DQ9 32 A6 22 A5 31 DQ1 A4 23 OE# 30 А3 24 29 GND Α2 25 28 Α1 26 27 A0

10.49mm

* Typical parameter in	ndicates the	value for	the center
of distribution, and n	ot 100% tes	sted.	

Pin	Function
A0 ~ A18	Address input
DQ1 ~ DQ16	Data input / output
S1#	Chip select input 1
S2	Chip select input 2
W#	Write control input
OE#	Output enable input
BC1#	Lower Byte (DQ1 ~ 8)
BC2#	Upper Byte (DQ9 ~ 16)
BYTE#	By te (x8 mode) enable input
Vcc	Power supply
GND	Ground supply

Outline: 52PTG-A N C: No Connection

8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

FUNCTION

The M5M5W817KT is organized as 524288-words by 16-bit / 1048576-words by 8-bit. These devices operate on a single +2.7~3.6V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1# , BC2# , S1#, S2 , W#, OE# and BYTE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address (A-1~A18: By te mode, A0~A18: Word mode) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1#and S2 are in an active state (S1#=L, S2=H).

When setting BYTE# at a low level, the function will be in the x8 mede, which is, DQ1-8 are available and DQ9-16 are not available. In the x8 mode, A-1 is used as the additional address. During the active function for x8 mode, BC1# BC2# must be low level.

When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled

In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as 0.1µA (25°C, typical), and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode

FUNCTION TABLE

S1#	S2	BYTE#	BC1#	BC2#	W#	OE#	Mode	DQ1~8	DQ9~15	DQ16	Icc
Н	Н	H or L	Χ	Χ	Χ	Χ	Non selection	High-Z	High-Z	High-Z	Standby
Χ	L	H or L	Χ	Χ	Χ	Χ	Non selection	High-Z	High-Z	High-Z	Standby
Χ	Χ	Н	Н	Н	Χ	Χ	Non selection	High-Z	High-Z	High-Z	Standby
L	Η	Н	L	Н	L	Χ	Write	Din	High-Z	High-Z	Active
L	Н	Н	L	Н	Н	L	Read	Dout	High-Z	High-Z	Active
L	Η	Н	L	Н	Η	Η		High-Z	High-Z	High-Z	Active
L	Н	Н	Н	L	L	Χ	Write	High-Z	Din	Din	Active
L	Η	Н	Н	L	Η	L	Read	High-Z	Dout	Dout	Active
L	Н	Н	Н	L	Н	Χ		High-Z	High-Z	High-Z	Active
L	Η	Н	L	L	L	Χ	Write	Din	Din	Din	Active
L	Н	Н	L	L	Н	L	Read	Dout	Dout	Dout	Active
L	Η	Н	L	L	Η	Χ		High-Z	High-Z	High-Z	Active
L	Н	L	L	L	L	Χ	Write	Din	High-Z	A-1	Active
L	Н	L	L	L	Н	L	Read	Dout	High-Z	A-1	Active
L	Н	L	Ĺ	Ĺ	Н	Н		High-Z	High-Z	A-1	Active

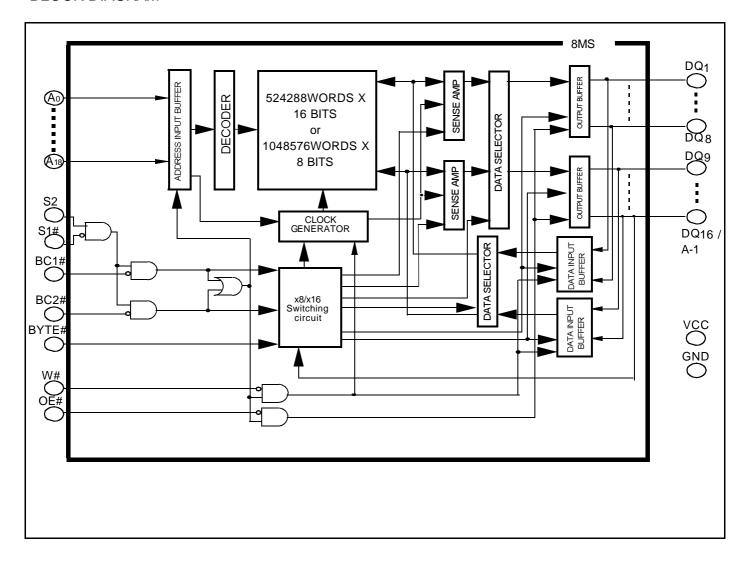
Note1: "H" and "L" in this table mean VIH and VIL, respectively.

Note2: "X" in this table should be "H" or "L".



8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

BLOCK DIAGRAM



8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Units
Vcc	Supply voltage	With respect to GND	- 0.3* ~ +4.6	
Vı	Input voltage	With respect to GND	- 0.3* ~ Vcc + 0.3 (max. 4.6V)	V
Vo	Output voltage	With respect to GND	0 ~ Vcc	
Pd	Power dissipation	Ta = 25°C	700	mW
Ta	Operating temperature		-40 ~ +85	∘C
Tstg	Storage temperature		- 65 ~ + 150	°C

^{* -3.0}V in case of AC (Pulse width ≤ 30ns)

DC ELECTRICAL CHARACTERISTICS (Ta=-40~85°C Vcc=2.7V~3.6V,unless otherwise noted)

Combal	Danamatan	One ditions			Limits	i	
Symbol	Parameter	Conditions		Min	Тур	Max	Units
VIH	High-lev el input v oltage			2.2		Vcc+0.2V	
VIL	Low-lev el input v oltage			- 0.2 *		0.6	
Vон	High-level output voltage	Iон= - 0.5mA		2.4			V
Vol	Low-level output voltage	IoL= 2.0mA				0.4	
- Ii	Input leakage current	Vı=0 ~ Vcc				±1	
lo	Output leakage current	BC1# and BC2#=VIH or S1#=VIH or S2=VIL or OE#=VIH,	VI/O=0 ~ Vcc			±1	μA
lcc1	Active supply current	BC1# and BC2# ≤ 0.2V, S1# ≤ 0.2V, S2 ≥Vcc-0.2V other inputs < 0.2V or > Vcc-0.2V	f= 10MHz	-	30	50	
ICC1	(AC,MOS level)	Output - open (duty 100%)	f= 1MHz	-	5	15	
	Active supply current	BC1# and BC2#=VIL , S1#=VIL ,S2=VIH other pins =VIH or VIL	f= 10MHz	-	30	50	mA
lcc2	(AC,TTL level)	Output - open (duty 100%)	f= 1MHz	-	5	15	
		(1) S1# ≥ Vcc - 0.2V and S2 ≥ Vcc - 0.2V, BYTE# ≥ Vcc - 0.2V or ≤ 0.2V, other inputs = 0 ~ Vcc	~ +25°C	-	1.0	5	
lcc3	Stand by supply current	(2) S2 ≤ 0.2V, BYTE# ≥ Vcc - 0.2V or ≤ 0.2V, other inputs = 0 ~ Vcc	~ +40°C	-	1.2	8	μA
	(AC,MOS level)	(3) BC1# and BC2# ≥ Vcc - 0.2V S1# ≤ 0.2V, S2 ≥ Vcc - 0.2V	~ +70°C	-	-	20	μΛ
		BYTE# \geq Vcc - 0.2V or \leq 0.2V, other inputs = 0 ~ Vcc	~ +85°C	-	-	40	
Icc4	Stand by supply current (AC,TTL level)	BC1# and BC2# =VIH or S1# =VIH or S2=VIL BYTE# \geq Vcc - 0.2V or \leq 0.2V, Other inputs= 0 \sim Vcc		-	-	2.0	mA

Note 3: Direction for current flowing into IC is indicated as positive (no mark)

CAPACITANCE (Ta=-40~+85°C Vcc=2.7V~3.6V,unless otherwise noted)

Symbol	Parameter	neter Conditions		Limits			
Syllibol	Parameter	Conditions	Min	Тур	Max	Units	
Сі	Input capacitance	V==GND, V=25mVrms, f=1MHz			10	pF	
Со	Output capacitance	Vo=GND,Vo=25mVrms, f=1MHz			10	рг	



^{* -1.0}V in case of AC (Pulse width \leq 30ns)

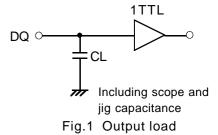
Note 4: Typical parameter indicates the value for the center of distribution at 3.0V, and not 100% tested.

8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

AC ELECTRICAL CHARACTERISTICS (Ta=-40~+85°C, Vcc=2.7V~3.6V,unless otherwise noted)

(1) TEST CONDITIONS

Supply voltage	2.7~3.6V	
Input pulse	VIH=2.7V, VIL=0).2V
Input rise time and fall time	5ns	
Reference level	VoH=VoL=1.5V	Transition is measured ±200mV from steady state voltage.(for ten,tdis)
Output loads	Fig.1,CL=30pF CL=5pF (1	for ten,tdis)



(2) READ CYCLE

Symbol	Parameter	Lin 70	Units	
Cymbol	. G.G.IIVIO	Min	Max	
tcr	Read cycle time	70		ns
ta(A)	Address access time		70	ns
ta(S1)	Chip select 1 access time		70	ns
ta(S2)	Chip select 2 access time		70	ns
ta(BC1)	By te control 1 access time		70	ns
ta(BC2)	Byte control 2 access time		70	ns
ta(OE)	Output enable access time		35	ns
tdis(S1)	Output disable time after S1# high		25	ns
tdis(S2)	Output disable time after S2 low		25	ns
tdis(BC1)	Output disable time after BC1# high		25	ns
tdis(BC2)	Output disable time after BC2# high		25	ns
tdis(OE)	Output disable time after OE# high		25	ns
ten(S1)	Output enable time after S1# low	10		ns
ten(S2)	Output enable time after S2 high	10		ns
ten(BC1)	Output enable time after BC1# low	5		ns
ten(BC2)	Output enable time after BC2# low	5		ns
ten(OE)	Output enable time after OE# low	5		ns
t∨(A)	Data valid time after address	10		ns

(3) WRITE CYCLE

Symbol	Parameter		Limits 70HI		
Gyllibol	i arameter	Min	Max		
tcw	Write cycle time	70		ns	
t _w (W)	Write pulse width	55		ns	
tsu(A)	Address setup time	0		ns	
tsu(A-WH)	Address setup time with respect to W#	65		ns	
tsu(BC1)	Byte control 1 setup time	65		ns	
tsu(BC2)	By te control 2 setup time	65		ns	
tsu(S1)	Chip select 1 setup time	65		ns	
tsu(S2)	Chip select 2 setup time	65		ns	
tsu(D)	Data setup time	35		ns	
th(D)	Data hold time	0		ns	
trec(W)	Write recovery time	0		ns	
tdis(W)	Output disable time from W# low		25	ns	
tdis(OE)	Output disable time from OE# high		25	ns	
ten(W)	Output enable time from W# high	5		ns	
ten(OE)	Output enable time from OE# low	5		ns	



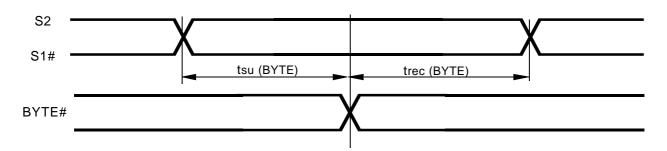
8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

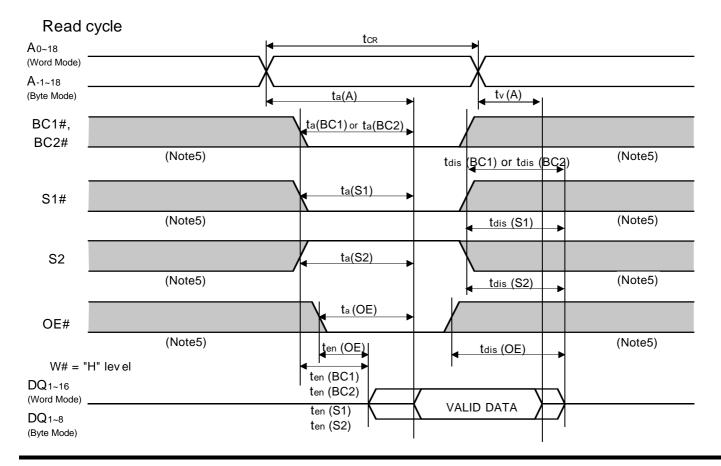
(4) Byte# function

Symbol	Parameter	Test conditions	Min	Тур	Max	Units
t su (BYTE)	BYTE# set up time		5			ms
trec (BYTE)	BYTE# recovery time		5			ms

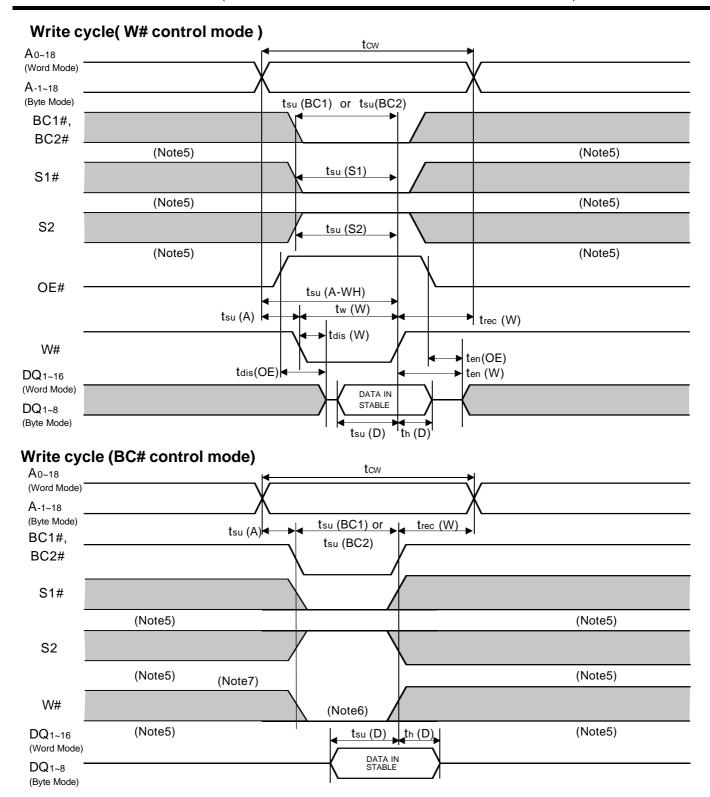
(5) TIMING DIAGRAMS







8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM



Note 5: Hatching indicates the state is "don't care".

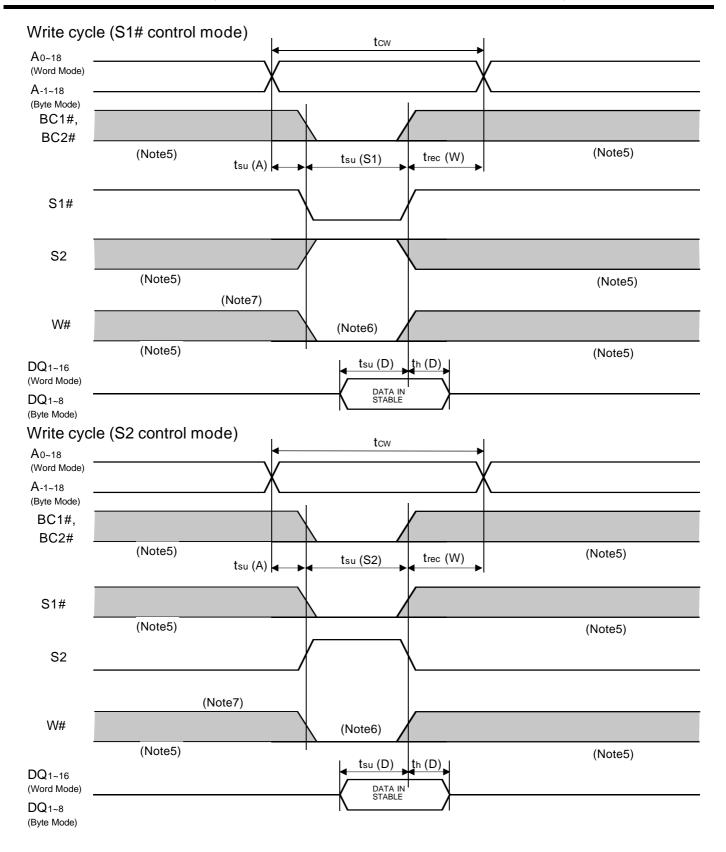
Note 6: A Write occurs during S1# low, S2 high overlaps BC1# and/or BC2# low and W# low.

Note 7: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.

Note 8: Don't apply inverted phase signal externally when DQ pin is in output mode.



8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM



8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS (Ta=-40~85°C, Vcc=2.7V~3.6V,unless otherwise noted)

	.				Limits		
Symbol	Parameter	Test conditions	Min	Тур	Max	Units	
Vcc (PD)	Power down supply voltage			2.0			V
VI (BC)	Byte control input BC1# & BC2#			2.0			V
VI (S1#)	Chip select input S1#			2.0			V
VI (S2)	Chip select input S2					0.2	
		Vcc=2.0V (1) S1# ≥ Vcc - 0.2V, BYTE# ≥ Vcc - 0.2V or ≤ 0.2V	~ +25°C	-	0.2	3.0	
Icc (PD)	Power down	other inputs = 0 ~ Vcc (2) S2 \leq 0.2V , BYTE# \geq Vcc - 0.2V or \leq 0.2V	~ +40°C	-	0.4	6.0	
()	supply current	other inputs = 0 ~ Vcc (3) BC1# and BC2# ≥ Vcc - 0.2V S1# < 0.2V, S2 > Vcc - 0.2V	~ +70°C	-	-	30	μΑ
		BYTE# \geq Vcc - 0.2V or \leq 0.2V other inputs = 0 ~ Vcc	~ +85°C	-	-	60	

(2) TIMING REQUIREMENTS

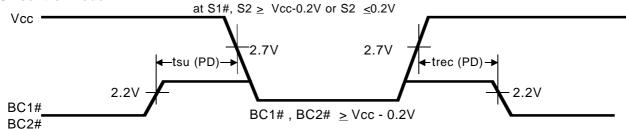
Note 9: Typical parameter of Icc(PD) indicates the value for the center of distribution at 2.0V, and not 100% tested.

Symbol	Parameter	Test conditions	Limits			
			Min	Тур	Max	Units
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

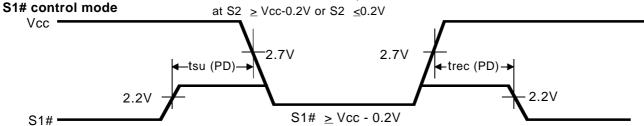
(3) TIMING DIAGRAM

BC# control mode

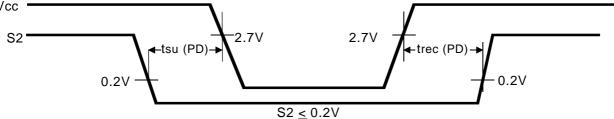
note10:On the BC# control mode, the level of S1# and S2 must be fixed



note11:On the S1# control mode, the level of S2 must be fixed



S2 control mode



8388608-BIT (524288-WORD BY 16-BIT / 10485776-WORD BY 8-BIT) CMOS STATIC RAM

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